

TOSHIBA CCD Linear Image Sensor CCD (Charge Coupled Device)

**TCD2724DG-1**

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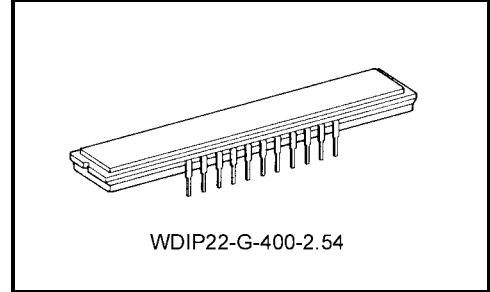
# TCD2724DG-1

The TCD2724DG-1 is a high sensitive and low dark current 7450 elements × 3 lines CCD color linear image sensor.

The device contains a row of 7450 elements × 3 lines photodiodes which provide 24 lines/mm across a A3 size paper. The device is operated by 3.3 V pulse and 10 V power supply.

### Features

- Number of Image Sensing Elements: 7450 elements × 3 lines
- Image Sensing Element Size: 4.7 μm by 4.7 μm on 4.7 μm center
- Photo Sensing Region: High sensitive PN photodiode
- Clock: 2-phase (3.3 V)
- Power Supply Voltage: 10 V (typ.)
- Distance between Photodiode Array: 18.8 μm (4 lines) R array – G array, G array – B array
- Internal Circuit: Clamp circuit, Sample and hold circuit, Low input capacitance
- Package: 22 pin CERDIP
- Color Filter: Red, Green, Blue

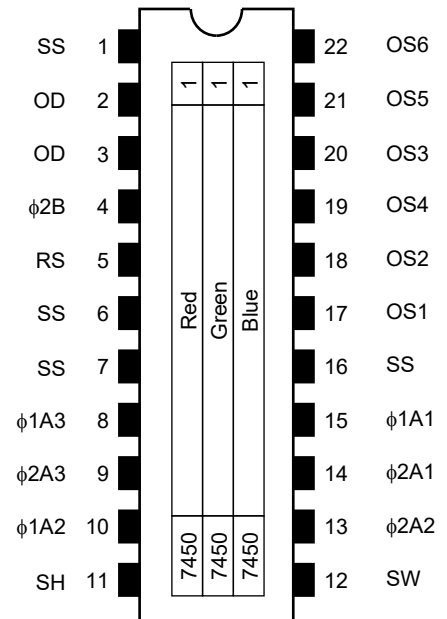


### ABSOLUTE MAXIMUM RATINGS (Note 1)

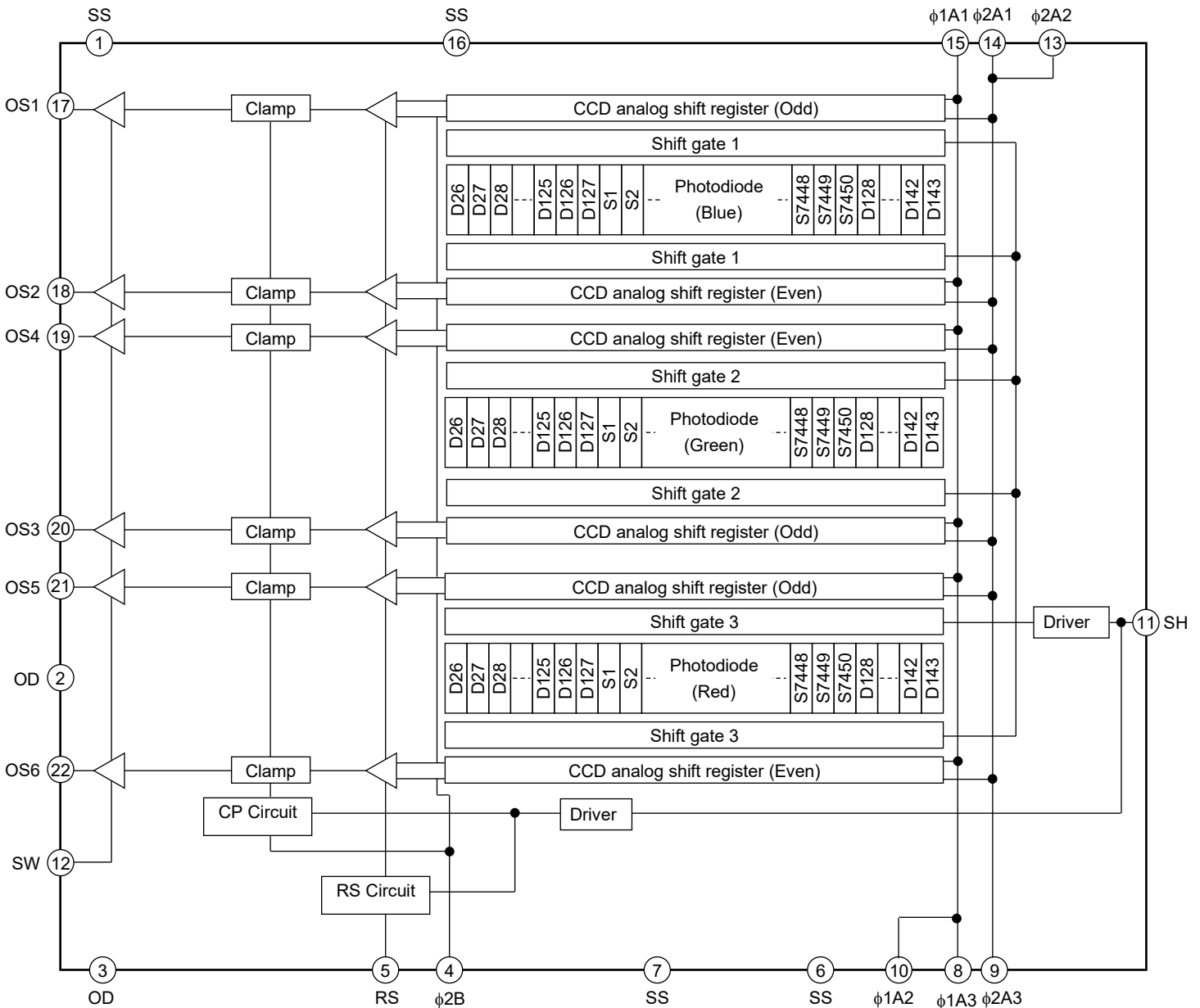
Characteristics	Symbol	Rating	Unit
Clock pulse voltage	$V_{\phi A}$	-0.3 to +8.0	V
Last stage clock pulse voltage	$V_{\phi B}$		
Shift pulse voltage	$V_{SH}$		
Reset pulse voltage	$V_{RS}$		
Switch pulse voltage	$V_{SW}$		
Power supply voltage	$V_{OD}$	-0.3 to +13.5	V
Operating temperature	$T_{opr}$	0 to 60	°C
Storage temperature	$T_{stg}$	-25 to +85	°C

Note 1: All voltages are with respect to SS terminals (ground).  
 None of the ABSOLUTE MAXIMUM RATINGS must be exceeded, even instantaneously.  
 If any one of the ABSOLUTE MAXIMUM RATINGS is exceeded, the electrical characteristics, reliability and life time of the device cannot be guaranteed. If the ABSOLUTE MAXIMUM RATINGS are exceeded, the device can be permanently damaged or degraded.  
 Create a system design in such a manner that any of the ABSOLUTE MAXIMUM RATINGS will not be exceeded under any circumstances.

### Pin Connections (top view)



### Circuit Diagram



### Pin Names

Pin No.	Symbol	Name	Pin No.	Symbol	Name
1	SS	Ground	22	OS6	Output signal 6 (Red(Even))
2	OD	Power supply	21	OS5	Output signal 5 (Red(Odd))
3	OD	Power supply	20	OS3	Output signal 3 (Green(Odd))
4	φ2B	Last stage transfer clock (phase 2)	19	OS4	Output signal 4 (Green(Even))
5	RS	Reset gate	18	OS2	Output signal 2 (Blue(Even))
6	SS	Ground	17	OS1	Output signal 1 (Blue(Odd))
7	SS	Ground	16	SS	Ground
8	φ1A3	Transfer clock 3 (phase 1)	15	φ1A1	Transfer clock 1 (phase 1)
9	φ2A3	Transfer clock 3 (phase 2)	14	φ2A1	Transfer clock 1 (phase 2)
10	φ1A2	Transfer clock 2 (phase 1)	13	φ2A2	Transfer clock 2 (phase 2)
11	SH	Shift gate	12	SW	Switch gate (Sample and hold output select)

### Optical/Electrical Characteristics

Ta = 25°C, VOD = 10 V, Vφ = VRS = VSH = 3.3 V (pulse), fφ = 1.0 MHz,  
 tINT (integration time) = 10 ms, light source = A light source + CM500S (t = 1.0 mm)

Characteristics		Symbol	Min	Typ.	Max	Unit	Note
Sensitivity Enable sample and hold	Red	RR	9.0	12.8	16.6	V/lx-s	(Note 2)
	Green	RG	10.5	15.0	19.5		
	Blue	RB	3.6	5.2	6.8		
Sensitivity Disable sample and hold	Red	RR	10.0	14.3	18.6		
	Green	RG	11.8	16.9	22.0		
	Blue	RB	4.0	5.8	7.5		
Photo response non uniformity		PRNU (1)	—	5	20	%	(Note 3)
		PRNU (3)	—	3	12	mV	(Note 4)
Saturation output voltage		VSAT	1.2	1.8	—	V	(Note 5)
Saturation exposure		SE	0.05	0.1	—	lx-s	(Note 6)
Dark signal voltage		VDRK	—	0.5	6	mV	(Note 7)
Dark signal non uniformity		DSNU	—	10	12	mV	(Note 8)
DC power dissipation		PD	—	700	1050	mW	—
Total transfer efficiency		TTE	92	97	—	%	—
Output impedance		ZO	—	0.2	0.5	kΩ	—
DC output signal voltage		VOS	3.7	5.2	6.7	V	(Note 9)
Random noise (Enable sample and hold)		NDσ	—	1.4	—	mV	(Note 10)
Random noise (Disable sample and hold)			—	1.1	—		

Note 2: Sensitivity is defined for each color of signal outputs average when the photosensitive surface is applied with the light of uniform illumination and uniform color temperature.

Note 3: PRNU (1) is defined for each color on a single chip by the expressions below when the photosensitive surface is applied with the light of uniform illumination and uniform color temperature, where measured approximately 600 mV of signal output.

$$PRNU (1) = \frac{\Delta X}{\bar{X}} \times 100 (\%)$$

$\bar{X}$ : Average of total signal outputs  
 $\Delta X$ : The maximum deviation from  $\bar{X}$

Note 4: PRNU (3) is defined as the maximum voltage with next pixel, where measured approximately 50 mV of signal output.

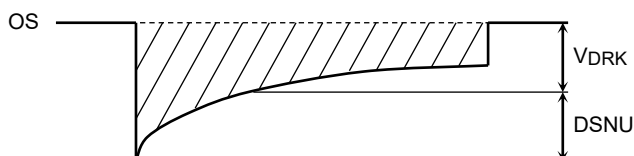
Note 5: VSAT is defined as the minimum saturation output voltage of all effective pixels.

Note 6: Definition of SE:

$$SE = \frac{V_{SAT}}{R_G}$$

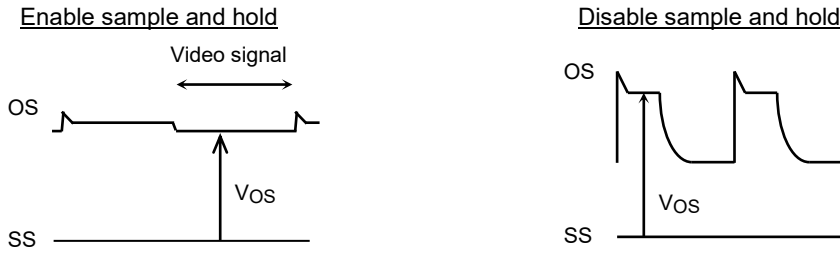
Note 7: VDRK is defined as average dark signal voltage of all effective pixels.

Note 8: DSNU is defined by the difference between average value (VDRK) and the maximum value of the dark voltage.



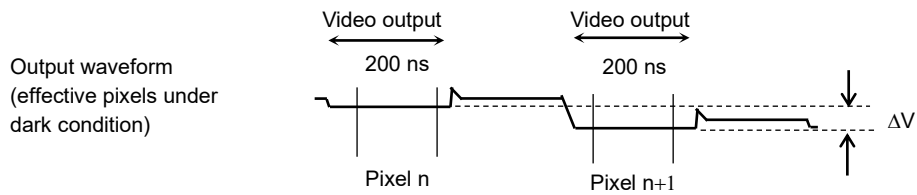
Note 9: DC output signal voltage is defined as follows.

Video signal with sample and hold represents the dummy outputs period.

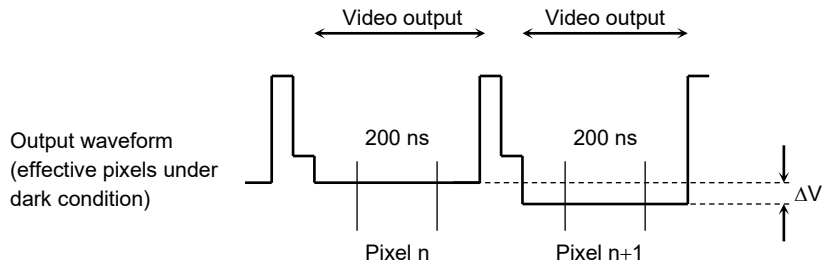


Note 10: Random noise is defined as the standard deviation (sigma) of the output level difference between two adjacent effective pixels under no illumination (i.e. dark condition) calculated by the following procedure.

### Enable sample and hold



### Disable sample and hold



- 1) Two adjacent pixels (pixel n and n+1) in one reading are fixed as measurement points.
- 2) Each of the output levels at video output periods averaged over 200 ns period to get \$V(n)\$ and \$V(n+1)\$.
- 3) \$V(n+1)\$ is subtracted from \$V(n)\$ to get \$\Delta V\$.

$$\Delta V = V(n) - V(n+1)$$

- 4) The standard deviation of \$\Delta V\$ is calculated after procedure 2) and 3) are repeated 30 times (30 readings).

$$\overline{\Delta V} = \frac{1}{30} \sum_{i=1}^{30} |\Delta V_i| \quad \sigma = \sqrt{\frac{1}{30} \sum_{i=1}^{30} (|\Delta V_i| - \overline{\Delta V})^2}$$

- 5) Procedure 2), 3) and 4) are repeated 10 times to get sigma value.
- 6) 10 sigma values are averaged.

$$\overline{\sigma} = \frac{1}{10} \sum_{j=1}^{10} \sigma_j$$

- 7) \$\overline{\sigma}\$ value calculated using the above procedure is observed \$\sqrt{2}\$ times larger than that measured relative to the ground level. So we specify the random noise as follows.

$$ND_{\sigma} = \frac{1}{\sqrt{2}} \overline{\sigma}$$

## Recommended Operating Conditions (Ta = 25°C)

For best performance, the device should be used within the Recommended Operating Conditions.

Characteristics		Symbol	Min	Typ.	Max	Unit
Clock pulse voltage	"H" level	$V_{\phi 1A}$	3.1	3.3	5.5	V
	"L" level	$V_{\phi 2A}$	0	0	0.1	
Last stage clock pulse voltage	"H" level	$V_{\phi 2B}$	3.1	3.3	5.5	V
	"L" level		0	0	0.1	
Shift pulse voltage	"H" level	$V_{SH}$	3.1	3.3	5.5	V
	"L" level		0	0	0.1	
Reset pulse voltage	"H" level	$V_{RS}$	3.1	3.3	5.5	V
	"L" level		0	0	0.1	
Switch pulse voltage	"H" level	$V_{SW}$	3.1	3.3	5.5	V
	"L" level		0	0	0.1	
Power supply voltage		$V_{OD}$	9.5	10.0	10.5	V

## Clock Characteristics (Ta = 25°C)

For best performance, the device should be used within the Recommended Operating Conditions.

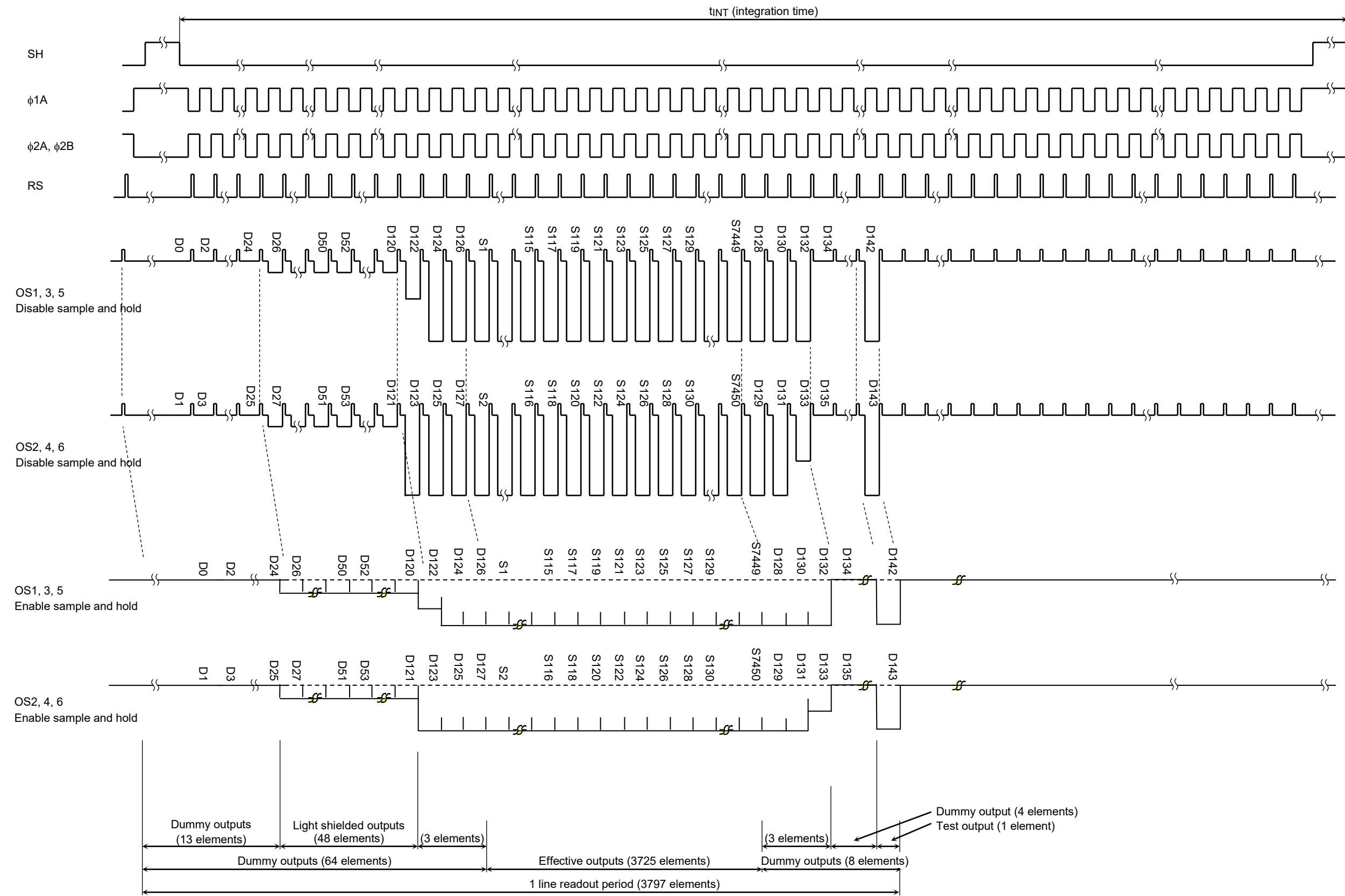
Characteristics	Symbol	Min	Typ.	Max	Unit
Clock pulse frequency	$f_{\phi}$	1.0	1.0	35.0	MHz
Reset pulse frequency	$f_{RS}$	1.0	1.0	35.0	MHz
Clock capacitance (Note 11)	$C_{\phi A}$	—	65	—	pF
Last stage clock capacitance	$C_{\phi B}$	—	7	—	pF
Shift gate capacitance	$C_{SH}$	—	20	—	pF
Reset gate capacitance	$C_{RS}$	—	7	—	pF

Note 11:  $V_{OD} = 10$  V, Input capacitance per a pin.

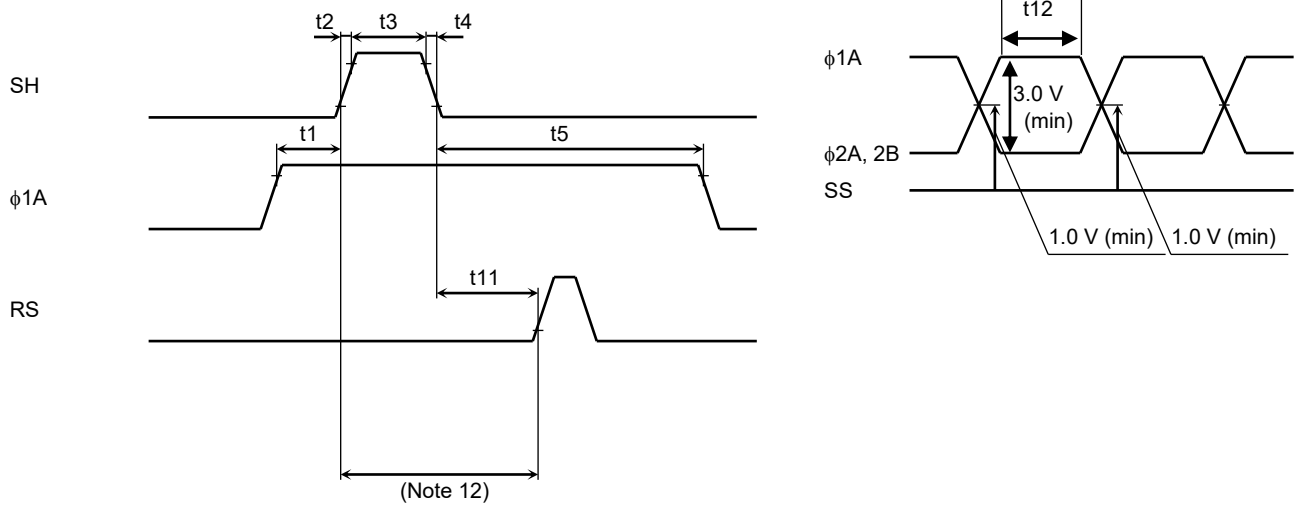
## Mode Select (Selection Sample and Hold)

Mode	SW
Enable sample and hold	"H"
Disable sample and hold	"L"

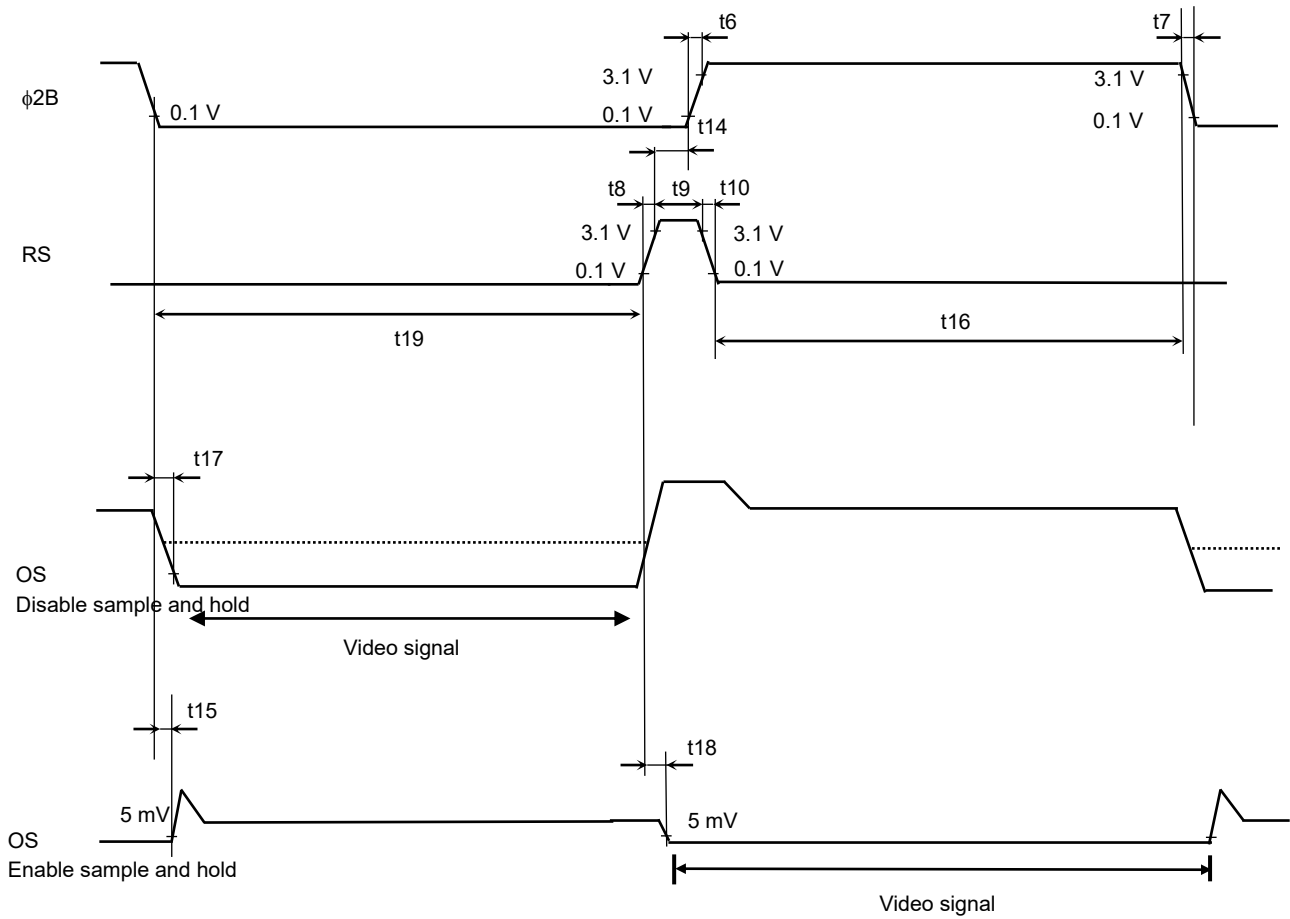
## Timing Chart 1



### Timing Requirements



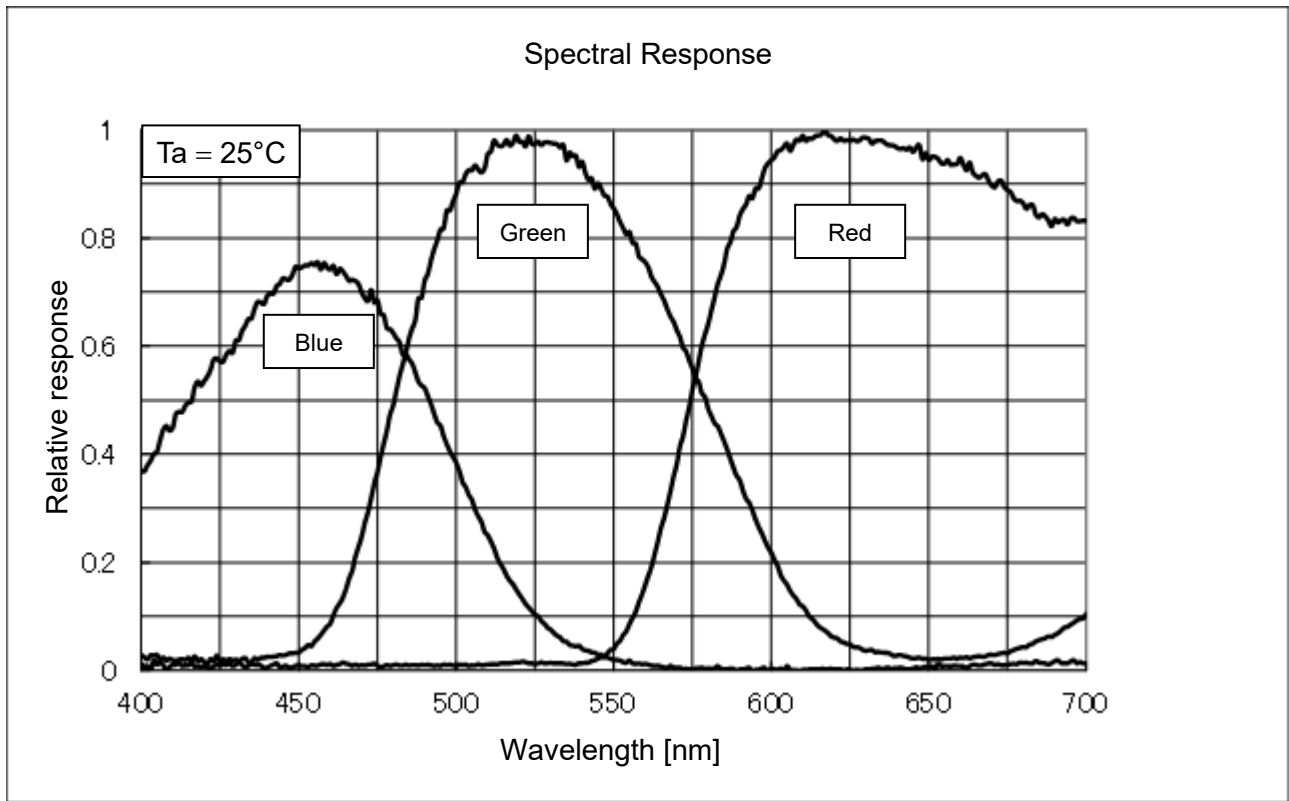
Note 12: Keep the RS pin "L" level.



Characteristics	Symbol	Min	Typ. (Note 13)	Max	Unit
Pulse timing of SH and $\phi$ 1A	t1	120	1000	—	ns
	t5	1000	1200	—	ns
SH pulse rise time, fall time	t2, t4	0	50	—	ns
SH pulse width	t3	2000	5000	—	ns
$\phi$ 2B pulse rise time, fall time	t6, t7	0	50	—	ns
RS pulse rise time, fall time	t8, t10	0	20	—	ns
RS pulse width	t9	6	100	—	ns
Pulse timing of SH and RS	t11	500	—	—	ns
$\phi$ 1A, $\phi$ 2A pulse width	t12	7	100	—	ns
Pulse timing of $\phi$ 2B and RS	t14	0	0	—	ns
	t16	6	100	—	ns
	t19	8	100	—	ns
Video data delay time	t17	—	7	—	ns
Video data delay time Enable sample and hold	t18	—	7	—	ns
$\phi$ 2B pulse timing of OS	t15	—	0	—	ns

Note 13: Measured with fRS = 1 MHz.

## Typical Spectral Response



## Cautions

### 1. Electrostatic Breakdown

Store in shorting clip or in conductive foam to avoid electrostatic breakdown.

CCD Image Sensor is protected against static electricity, but inferior puncture mode device due to static electricity is sometimes detected. In handling the device, it is necessary to execute the following static electricity preventive measures, in order to prevent the trouble rate increase of the manufacturing system due to static electricity.

- a. Prevent the generation of static electricity due to friction by making the work with bare hands or by putting on cotton gloves and non-charging working clothes.
- b. Discharge the static electricity by providing earth plate or earth wire on the floor, door or stand of the work room.
- c. Ground the tools such as soldering iron, radio cutting pliers or pincer.
- d. Ionized air is recommended for discharge when handling CCD image sensors.

It is not necessarily required to execute all precaution items for static electricity.

It is all right to mitigate the precautions by confirming that the trouble rate within the prescribed range.

### 2. Window Glass

The dust and stain on the glass window of the package degrade optical performance of CCD sensor.

Keep the glass window clean by saturating a cotton swab in alcohol and lightly wiping the surface, and allow the glass to dry, by blowing with filtered dry N<sub>2</sub>. Care should be taken to avoid mechanical or thermal shock because the glass window is easily to damage.

### 3. Incident Light

CCD sensor is sensitive to infrared light. Note that infrared light component degrades resolution and PRNU of CCD sensor.

### 4. Mounting on a PCB

This package is sensitive to mechanical stress.

TOSHIBA recommends using IC inserters for mounting, instead of using lead forming equipment.

Since this package is not strong against mechanical stress, you should not reform the lead frame.

We recommend to use an IC-inserter when you assemble to PCB.

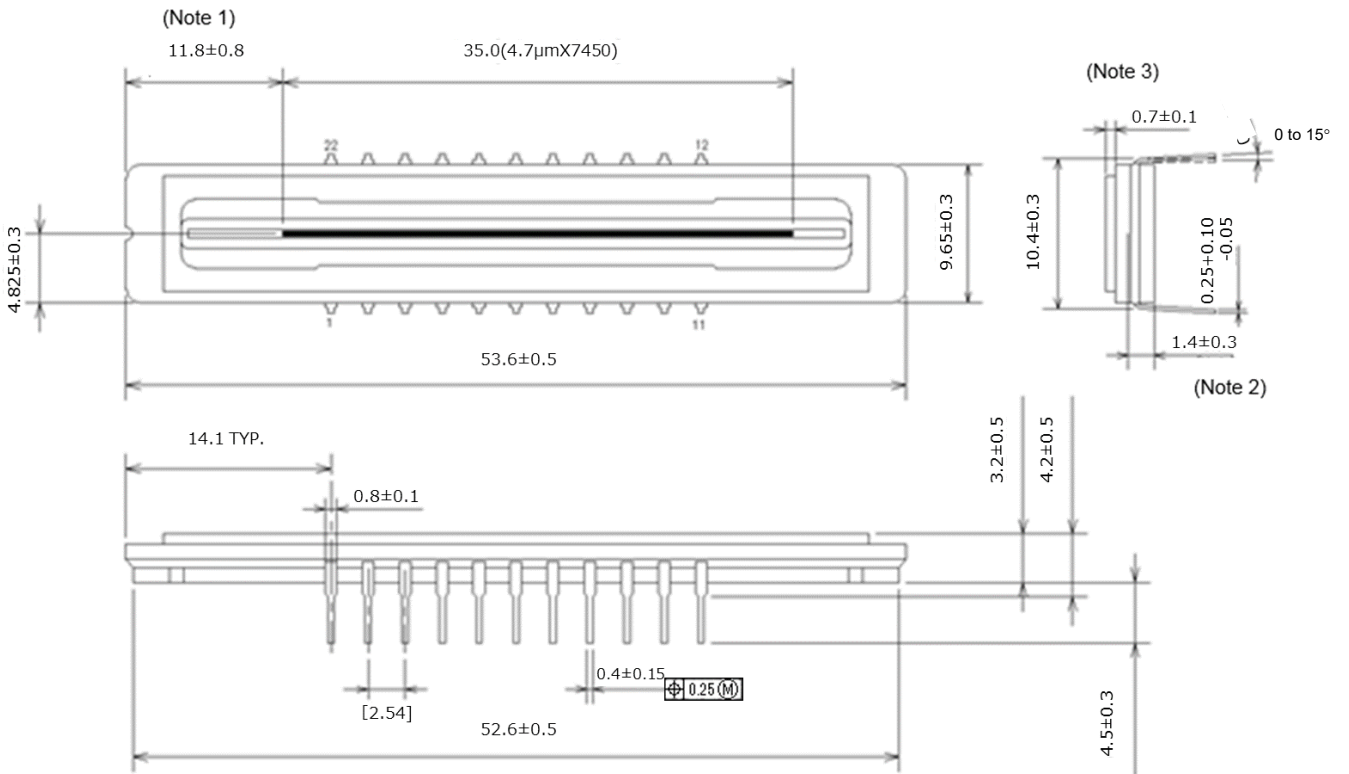
### 5. Soldering

Soldering by the solder flow method cannot be guaranteed because this method may have deleterious effects on prevention of window glass soiling and heat resistance.

Using a soldering iron, complete soldering within three seconds for lead temperatures of up to 350°C.

### Package Dimensions

WDIP22-G-400-2.54



Unit: mm

Note 1: Distance between the edge of the package and the first pixel (S1)

Note 2: Distance between the top of chip and bottom of the package

Note 3: Glass thickness (n = 1.5)

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